## Application/Control No. Applicant(s)/Patent Under Reexamination 10/044,565 KUKREJA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Greg Bengzon 2144 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0205243 A1 10-2004 Hurvig et al. Α 709/245 \* US-2003/0120948 A1 06-2003 Schmidt et al. В 713/200 US-С US-5,619,657 A 04-1997 Sudama et al. D 709/225 \* US-7,039,697 B2 05-2006 Bayles, Len Albert Ε 709/223 F US-2002/0112045 A1 08-2002 Nirkhe et al. 709/223 \* US-2002/0156879 A1 10-2002 G Delany et al. 709/223 US-2003/0131073 A1 07-2003 Lucovsky et al. Н 709/219 \* US-2002/0143773 A1 10-2002 Spicer et al. 707/10 US-J US-K US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code Name Classification MM-YYYY WO 02/073926 09-2002 DK Ν Hurvig H04L 29/06 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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